

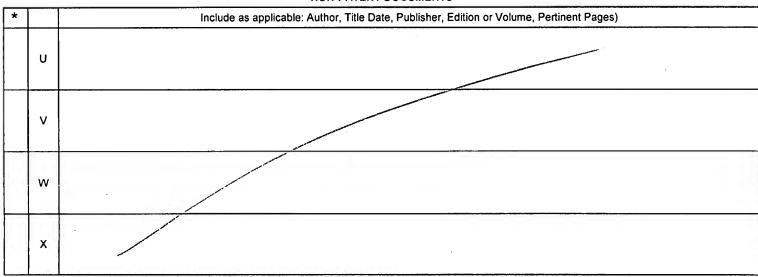
U.S. PATENT DOCUMENTS

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)	לעו	Application Number	10/702,235
RMATION	DISCLOS	MRE	Filing Date	November 5, 2003
TEMENT B	Y XPPLIE	ANT	First Named Inventor	Salmon, Peter C.
			Art Unit	2813
(Use as many shee	ts as necessary)		Examiner Name	Harrison, Monica D.
2	of	2	Attorney Docket Number	000939-119030US
	PRMATION TEMENT B	PRMATION DISCLOS TEMENT BY APPLIC	PRMATION DISCLOSURE TEMENT BY APPLICANT	Application Number Application Number Filing Date First Named Inventor Art Unit (Use as many sheets as necessary) Examiner Name

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Examiner		Fo	reign Patent Do	cument	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages	
Initials*	No.¹	Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	or Relevant Figures Appear	
MDH	28	EP	1089331	A2	04-04-2001	PFC Corporation		
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MDG	30	J. Lynn Davis and J. Kevin Arledge, "Thin Film Metallization of Three Dimensional Substrates," 1-4 May 1994, Electronic Components Technology Conference, Proceedings 44th, pp. 359-361	

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